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LED ARRAY

LA175B/G.SRG.G.2X-S1

DATA SHEET

DOC. NO : QW0905-LA175B/G.SRG.G.2X-S1

REV. : A

DATE : 23 - Sep. - 2005



Top View: The module has a total width of 44. It features three circular LEDs labeled '1st', '2nd', and '3rd' with 'G' (Green) color coding. Between the 1st and 2nd LEDs is an 'SRG' (Surface Mount Rectifier) component. Dimensions include a pin pitch of 2.54 TYP and a total pin width of 2.9±0.3. A detail view shows a hole with a diameter of Ø 3.25 and a depth of 5.08, with a total thickness of 7.4.

Pin Configuration:

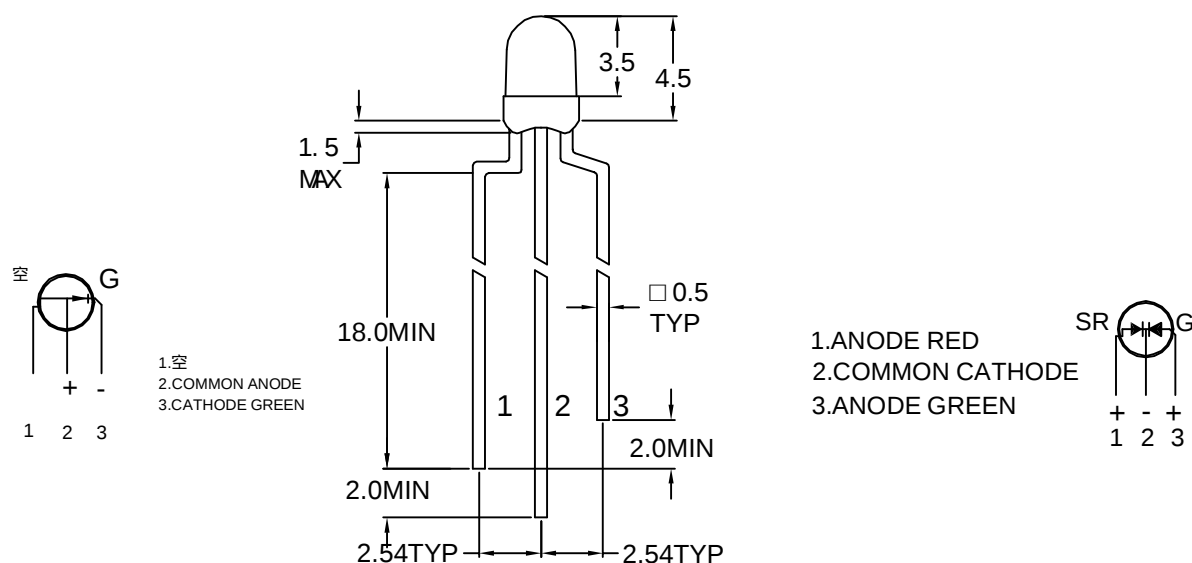
Pin	1	2	3	4	5	6	7	8	9	10
Function	空	+	-	+	-	+	空	+	-	
Color	1	2	3	1	2	3	1	2	3	

Side View: Shows a height of 4.75±0.5 and a mounting tab width of 1.5±0.3. The tab has a width of 6.5. A detail view shows a hole with a diameter of Ø 0.5 TYP.

LED Symbol Details:

- LED 1:** Symbol with 'G' and '+' on pin 1, '-' on pin 2. Legend: 1.空, 2.COMMON ANODE, 3.CATHODE GREEN.
- LED 2:** Symbol with 'SR' and '+' on pin 1, '-' on pin 2. Legend: 1.ANODE RED, 2.COMMON CATHODE, 3.ANODE GREEN.

LSRG32692/S6(2nd)



Note : 1.All dimension are in millimeter tolerance is $\pm 0.25\text{mm}$ unless otherwise noted.
2.Specifications are subject to change without notice.



Absolute Maximum Ratings at Ta=25 °C

Parameter	Symbol	Ratings		UNIT
		G	SR	
Forward Current	IF	30	30	mA
Peak Forward Current Duty 1/10@10KHz	IFP	120	100	mA
Power Dissipation	PD	100	100	mW
Reverse Current @5V	Ir	10		μA
Operating Temperature	Topr	-40 ~ +85		°C
Storage Temperature	Tstg	-40 ~ +100		°C
Soldering Temperature	Tsol	Max 260°C for 5 sec Max (2mm from body)		

Typical Electrical & Optical Characteristics (Ta=25 °C)

PART NO	MATERIAL	COLOR		Peak wave length λ Pnm	Spectral halfwidth Δ λ nm	Forward voltage @20mA(V)		Luminous intensity @ 20 mA(mcd)		Viewing angle 2 θ 1/2 (deg)
		Emitted	Lens			Min.	Max.	Min.	Typ.	
LA175B/G.SRG.G.2X-S1	GaP	Green	Green Diffused	565	30	1.7	2.6	9.0	15	136
	GaAlAs	Red	White Diffused	660	20	1.5	2.4	6.5	12	132
	GaP	Green		565	30	1.7	2.6	21	38	132

Note : 1.The forward voltage data did not including ±0.1V testing tolerance.

2. The luminous intensity data did not including ±15% testing tolerance.



Typical Electro-Optical Characteristics Curve

G CHIP

Fig.1 Forward current vs. Forward Voltage

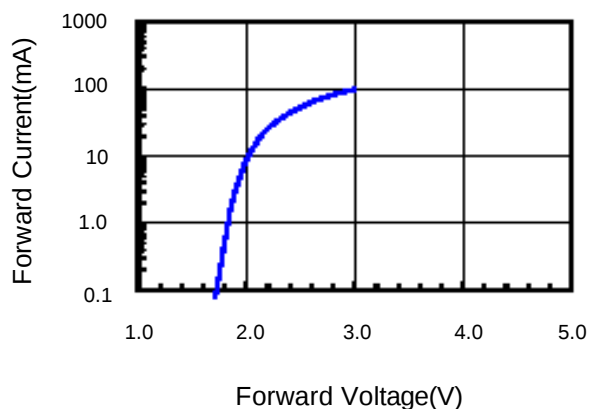


Fig.2 Relative Intensity vs. Forward Current

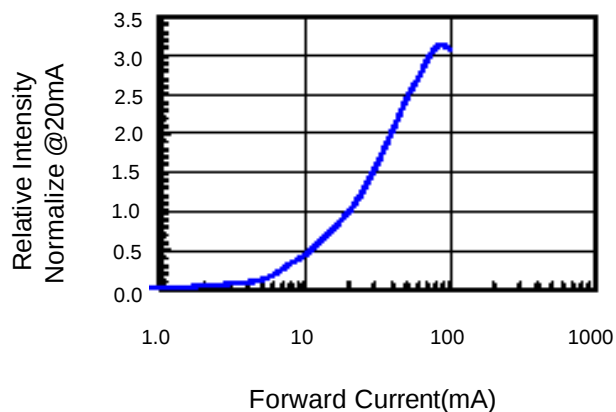


Fig.3 Forward Voltage vs. Temperature

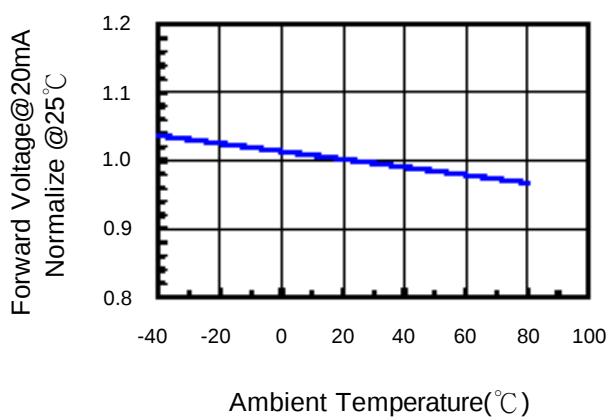


Fig.4 Relative Intensity vs. Temperature

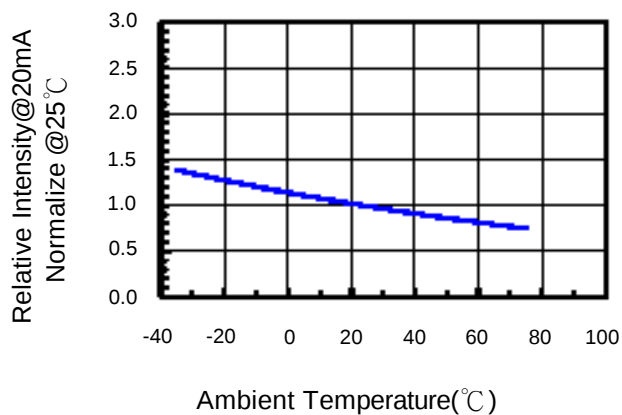
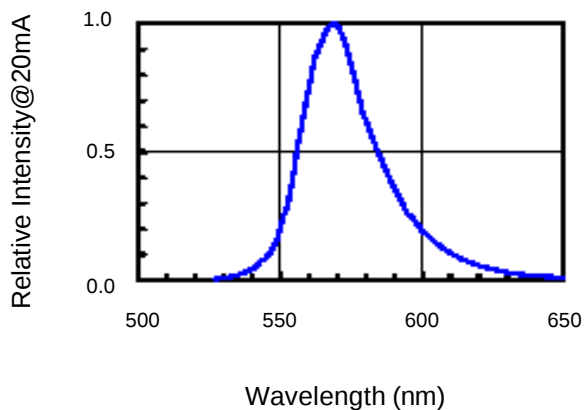


Fig.5 Relative Intensity vs. Wavelength





Typical Electro-Optical Characteristics Curve

SR CHIP

Fig.1 Forward current vs. Forward Voltage

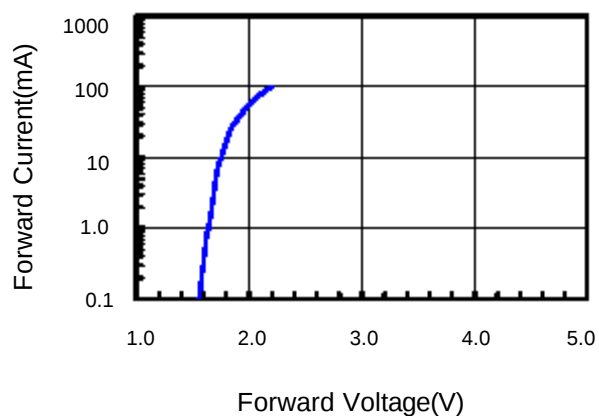


Fig.2 Relative Intensity vs. Forward Current

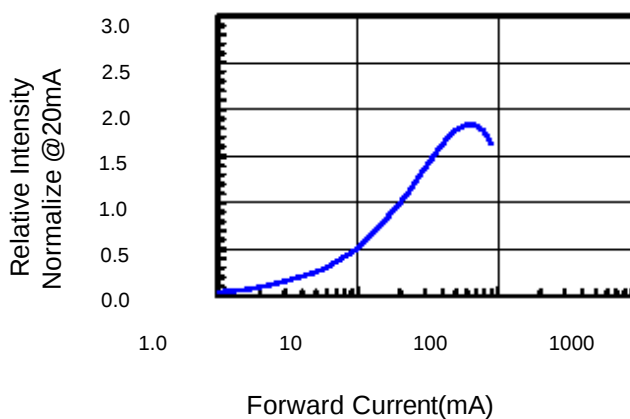


Fig.3 Forward Voltage vs. Temperature

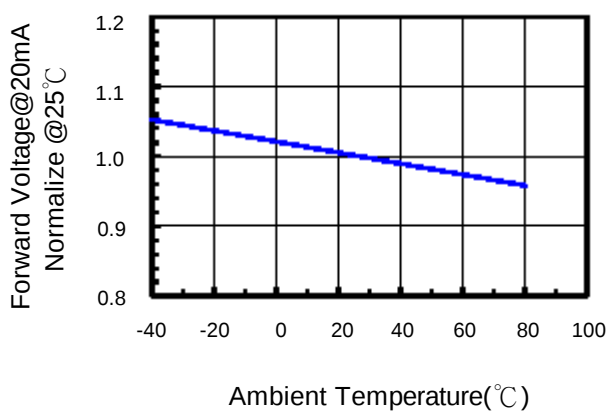


Fig.4 Relative Intensity vs. Temperature

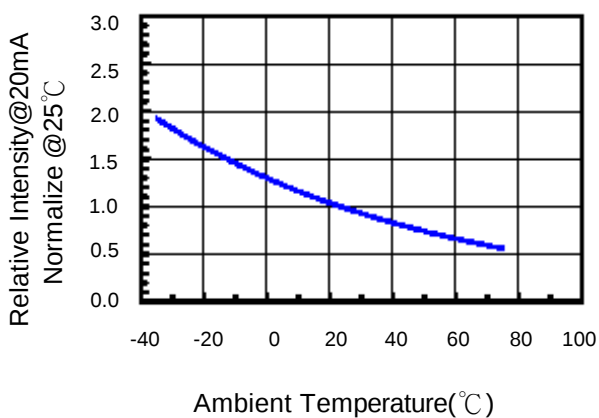
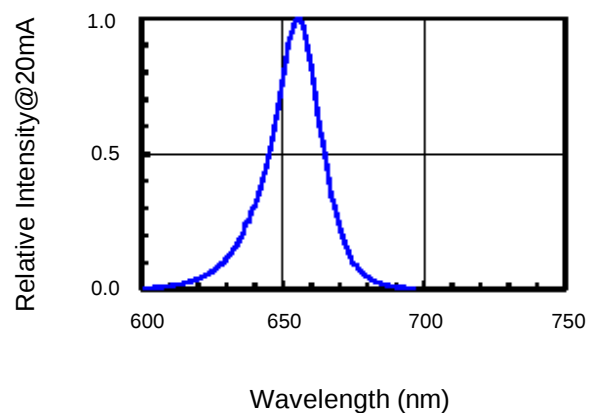


Fig.5 Relative Intensity vs. Wavelength



**Reliability Test:**

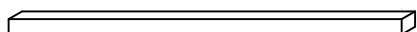
Test Item	Test Condition	Description	Reference Standard
Operating Life Test	1.Under Room Temperature 2.If=20mA 3.t=1000 hrs (-24hrs, +72hrs)	This test is conducted for the purpose of determining the resistance of a part in electrical and thermal stressed.	MIL-STD-750: 1026 MIL-STD-883: 1005 JIS C 7021: B-1
High Temperature Storage Test	1.Ta=105 °C±5°C 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of high temperature for hours.	MIL-STD-883:1008 JIS C 7021: B-10
Low Temperature Storage Test	1.Ta=-40 °C±5°C 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of low temperature for hours.	JIS C 7021: B-12
High Temperature High Humidity Test	1.Ta=65 °C±5°C 2.RH=90 %~95% 3.t=240hrs ±2hrs	The purpose of this test is the resistance of the device under tropical for hours.	MIL-STD-202:103B JIS C 7021: B-11
Thermal Shock Test	1.Ta=105 °C±5°C & -40 °C±5°C (10min) (10min) 2.total 10 cycles	The purpose of this is the resistance of the device to sudden extreme changes in high and low temperature.	MIL-STD-202: 107D MIL-STD-750: 1051 MIL-STD-883: 1011
Solder Resistance Test	1.T.Sol=260 °C±5°C 2.Dwell time= 10 ±1sec.	This test intended to determine the thermal characteristic resistance of the device to sudden exposures at extreme changes in temperature when soldering the lead wire.	MIL-STD-202: 210A MIL-STD-750: 2031 JIS C 7021: A-1
Solderability Test	1.T.Sol=230 °C±5°C 2.Dwell time=5 ±1sec	This test intended to see soldering well performed or not.	MIL-STD-202: 208D MIL-STD-750: 2026 MIL-STD-883: 2003 JIS C 7021: A-2



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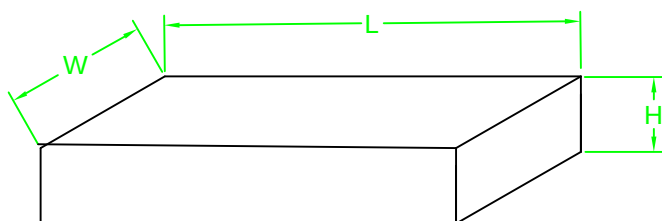
PACKING SPECIFICATION

1. 11PCS / TUBE



2. 126 TUBES / INNER BOX

SIZE : L X W X H 55cm X 22.5cm X 10cm



3. 4 INNER BOXES / CARTON

SIZE : L X W X H 56.5cm X 47.5cm X 24cm

